DECEMBER 1983-REVISED MARCH 1988

- Package Options Include Plastic 'Small Outline' Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

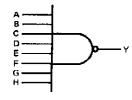
These devices contain a single 8-input NAND gate.

The SN5430, SN54LS30, and SN54S30 are characterized for operation over the full military range of $-55\,^{\circ}\text{C}$ to $125\,^{\circ}\text{C}$. The SN7430, SN74LS30, and SN74S30 are characterized for operation from $0\,^{\circ}\text{C}$ to $70\,^{\circ}\text{C}$.

FUNCTION TABLE

INPUTS A THRU H	OUTPUT Y
All inputs H	L
One or more inputs L	H

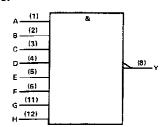
logic diagram



positive logic

$$Y = \overline{A \cdot B \cdot C \cdot D \cdot E \cdot F \cdot G \cdot H} \quad \text{or} \quad Y = \overline{A} + \overline{B} + \overline{C} + \overline{D} + \overline{E} + \overline{F} + \overline{G} + H$$

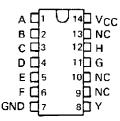
logic symbol †



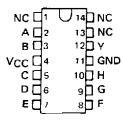
[†]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

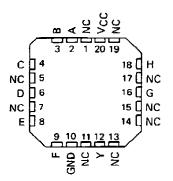
SN5430 . . . J PACKAGE SN54LS30, SN64S30 . . . J OR W PACKAGE SN7430 . . . N PACKAGE SN74LS30, SN74S30 . . . D OR N PACKAGE (TOP VIEW)



SN5430 . . . W PACKAGE (TOP VIEW)

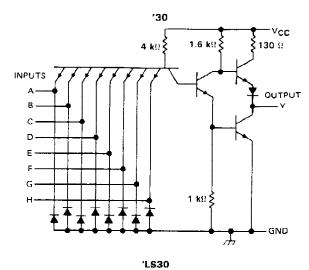


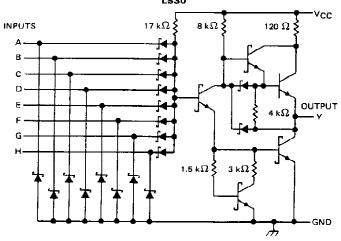
SN54LS30, SN54S30...FK PACKAGE (TOP VIEW)

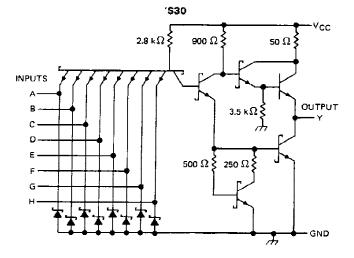


NC - No internal connection

schematics (each gate)







Resistor values shown are nominal.



POST OFFICE BOX 655012 . DALLAS, TEXAS 75265

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)		7 V
Input voltage		5.5 V
Operating free-air temperature range:	SN5430	55°C to 125°C
	SN7430	
Storage temperature range		65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

			SN5430)				
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.75	6	5.25	V
V _{IH}	High-level input voltage	2			2			٧
VIL	Low-level input voltage			0.8			0.8	V
¹он	High-level output current			- 0.4			- 0.4	mA
IOL	Low-level output current			16			16	mΑ
ТД	Operating free-air temperature	<i>–</i> 55		125	0		70	°Ç

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †			SN5430			SN743	10	TINU
FARAMEIER	i			TYP‡	MAX	MIN	TYP‡	MAX	UNII
VIK	V _{CC} = MIN,	I _I = -12 mA			1.5			- 1.5	v
V _{OH}	V _{CC} = MIN,	V _{IL} = 0.8 V, I _{OH} 0.4 mA	2.4	3.4		2.4	3.4		٧
VOL	V _{CC} = MIN,	V _{IH} = 2 V, I _{OL} = 16 mA		0.2	0.4		0.2	0.4	V
7	V _{CC} = MAX,	V = 5.5 V			1			1	mA
ЧН	V _{CC} = MAX,	V ₁ = 2.4 V			40			40	μА
IL	VCC = MAX,	V† = 0.4 V			1.6			~ 1.6	mΑ
los§	V _{CC} = MAX		- 20		- 55	- 18		- 55	mA
Ісс н	V _{CC} = MAX,	V ₁ = 0		1	2		1	2	mΑ
lccr	V _{CC} = MAX,	V ₁ = 4.5 V		3	6		3	6	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPLH		.,			13	22	ns
tPHL.	Апу	Y	R _L = 400 Ω, C _L = 15 pF		8	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C. § Not more than one output should be shorted at a time.

SN54LS30, SN74LS30 8-INPUT POSITIVE-NAND GATES

absolute maximum ratings over operating free-air temperature range (unless otherwise noted) Input voltage 7 V SN74LS30 0°C to 70°C

Storage temperature range -65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		•	SN54LS30		SN74LS30			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
νін	High-level input voltage	2			2			٧
VIL	Low-level input voltage			0.7			8.0	٧
ЮН	High-level output current			- 0.4			- 0.4	mΑ
loL	Low-level output current			4			8	mΑ
TA	Operating free-air temperature	– 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS †			SN54LS	30		SN74LS	30	UNIT	
PARAMETER			MIN	TYP‡	MAX	MIN	TYP‡	MAX	ONI	
Vik	VCC = MIN,	I _I = — 18 mA				- 1.5			– 1.5	٧
∨он	VCC = MIN,	VIL = MAX,	I _{OH} = - 0.4 mA	2.5	3.4		2.7	3.4		٧
	V _{CC} = MIN,	V _{1H} = 2 V,	I _{OL} = 4 mA		0.25	0.4			0.4	v
VOL	V _{CC} ≠ MIN,	V _{IH} = Z V,	IOL = 8 mA					0.25	0.5	
11	V _{CC} = MAX,	V ₁ = 7 V				0.1			0.1	mA
ЧН	V _{CC} = MAX,	V ₁ = 2.7 V				20			20	μА
lir.	V _{CC} = MAX,	V _J = 0.4 V				- 0.4			- 0.4	mΑ
los§	V _{CC} = MAX			- 20		- 100	- 20		- 100	mA
ICCH	V _{CC} = MAX,	V ₁ = 0			0.35	0.5		0.35	0.5	mΑ
Iccr	V _{CC} = MAX,	V _I = 4.5 V			0.6	1.1		0.6	1.1	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, VCC = 5 V, TA = 25°C (see note 2)

PARAMETER	FROM (INPUT)	TO {QUTPUT}	TEST CONDITIONS		TYP	MAX	UNIT
[†] PLH	A = 1.1	V	$R_{\parallel} = 2 k \Omega$, $C_{\parallel} = 15 pF$		8	15	ns
tPHL	Any	,	AL - 2 K12, CL - 19 PF		13	20	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)	7 V
Input voltage	5.5 V
Operating free-air temperature range: SN54S30	
SN74S30	
Storage temperature range	

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

			SN5483	0	SN74S30			UNIT
	<u></u>	MIN	NOM	MAX	MIN	NOM	MAX	UNTI
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
VIΗ	High-level input voltage	2			2			٧
VIL	Low-level input voltage			0.8			0.8	٧
'он	High-level output current			-1			- 1	mA
JOL	Low-level output current			20			20	mA
TA	Operating free-air temperature	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

04.0445750	TEST CONDITIONS †	SN54S30	SN74S30	UNIT
PARAMETER	TEST CONDITIONS I	MIN TYP\$ MAX	MIN TYP‡ MAX	UNIT
VIK	V _{CC} = MIN, I _I = -18 mA	-1.2	-1.2	٧
Voн	V _{CC} = MIN, V _{IL} = 0.8 V, I _{OH} = -1 mA	2.5 3.4	2.7 3.4	٧
VOL	V _{CC} = MIN, V _{IH} = 2 V, I _{OL} = 20 mA	0,5	0.5	٧
Ħ	V _{CC} - MAX, V _I - 5.5 V	1	1	mA
ЧΗ	V _{CC} = MAX, V _I = 2.7 V	50	50	μΑ
lp_	V _{CC} = MAX, V ₁ = 0.5 V	-2	-2	mA
IOS §	V _{CC} = MAX	-40100	40 -100	mA
^I ссн	V _{CC} = MAX, V _I = 0	3 5	3 5	mΑ
ICCL	V _{CC} = MAX, V _I = 4.5 V	5.5 10	5.5 10	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
[†] PLH		Y	$R_1 = 280 \Omega$, $C_1 = 15 pF$		4	6	ns
tPHL.			11 200 11, CE + 13 pr		4.5	7	ns
t PL H	Any		D. = 200 C. = 50 m5		5.5		กร
^t PHL			R _L = 280 Ω, C _L = 50 pF		6.5		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 6 \text{ V}$, $T_A = 25^{\circ}C$.
§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

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